



## SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

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Report No.: SZEM170300179205  
Page: 1 of 8

# RF Exposure Evaluation Report

<b>Application No.:</b>	SZEM1703001792CR
<b>Applicant:</b>	ADMOBILIZE LLC
<b>Address of Applicant:</b>	1680 Michigan Avenue Suite 918, Miami Beach, Florida, United States
<b>Manufacturer:</b>	EMBEST TECHNOLOGY CO.,LTD.
<b>Address of Manufacturer:</b>	Tower B 4/F, Shanshui Building, Nanshan Yungu Innovation Industry Park, Liuxian Ave.No.1183, Nanshan District, Shenzhen, Guangdong, China
<b>Factory:</b>	EMBEST TECHNOLOGY CO.,LTD.
<b>Address of Factory:</b>	Tower B 4/F, Shanshui Building, Nanshan Yungu Innovation Industry Park, Liuxian Ave.No.1183, Nanshan District, Shenzhen, Guangdong, China
<b>Equipment Under Test (EUT):</b>	
<b>EUT Name:</b>	MATRIX Creator
<b>Model No.:</b>	MATRIX.C1.US
<b>FCC ID:</b>	2ALM5-MTxC1
<b>Standards:</b>	47 CFR Part 1.1307 (2016) 47 CFR Part 1.1310 (2016) KDB447498D01 General RF Exposure Guidance v06
<b>Date of Receipt:</b>	2017-03-15
<b>Date of Test:</b>	2017-03-17 to 2017-04-18
<b>Date of Issue:</b>	2017-04-27

<b>Test Result :</b>	<b>Pass*</b>
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\* In the configuration tested, the EUT complied with the standards specified above.



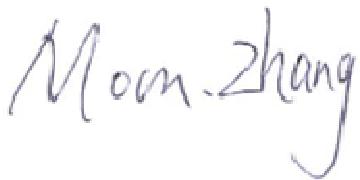
Jack Zhang  
EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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## 2 Version

<b>Revision Record</b>				
<b>Version</b>	<b>Chapter</b>	<b>Date</b>	<b>Modifier</b>	<b>Remark</b>
01		2017-04-27		Original

<b>Authorized for issue by:</b>			
<b>Tested By</b>			2017-04-18
		<b>Moon Zhang /Project Engineer</b>	<b>Date</b>
<b>Checked By</b>			2017-04-27
		<b>Eric Fu /Reviewer</b>	<b>Date</b>

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## 4 General Information

### 4.1 Details of E.U.T.

EUT Name:	MATRIX Creator
Model No.:	MATRIX.C1.US
Power Supply:	DC 5V
<b>For Zigbee:</b>	
Frequency Range:	2405MHz to 2480MHz
Modulation Type:	O-QPSK
Number of Channels:	16
Sample Type:	Mobile device
Antenna Type:	Chip Antenna
Antenna Gain:	0.5dBi
<b>For Zwave:</b>	
Operation Frequency:	908.4MHz, 916MHz
Modulation:	GFSK
Antenna Type:	Chip Antenna
Antenna Gain:	1.2dBi
<b>For NFC:</b>	
Operation Frequency:	13.56MHz
Antenna Type:	MicroStrip Loop Inductor Antenna
Antenna Gain:	0dBi

## 4.2 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch E&E Lab

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China  
518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.

## 4.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- **VCCI**

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

- **FCC – Registration No.: 556682**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

- **Industry Canada (IC)**

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

## 4.4 Deviation from Standards

None.

## 4.5 Abnormalities from Standard Conditions

None.

## 4.6 Other Information Requested by the Customer

None.

## 5 RF Exposure Evaluation

### 5.1 RF Exposure Compliance Requirement

#### 5.1.1 Limits

According to FCC Part1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in part1.1307(b)

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm <sup>2</sup> )	Averaging time (minutes)
<b>(A) Limits for Occupational/Controlled Exposures</b>				
0.3–3.0 .....	614	1.63	*(100)	6
3.0–30 .....	1842/f	4.89/f	*(900/f <sup>2</sup> )	6
30–300 .....	61.4	0.163	1.0	6
300–1500 .....	.....	.....	f/300	6
1500–100,000 .....	.....	.....	5	6
<b>(B) Limits for General Population/Uncontrolled Exposure</b>				
0.3–1.34 .....	614	1.63	*(100)	30
1.34–30 .....	824/f	2.19/f	*(180/f <sup>2</sup> )	30
30–300 .....	27.5	0.073	0.2	30
300–1500 .....	.....	.....	f/1500	30
1500–100,000 .....	.....	.....	1.0	30

F= Frequency in MHz

Friis Formula

Friis transmission formula:  $P_d = (P_{out} \cdot G) / (4 \cdot \pi \cdot R^2)$

Where

$P_d$  = power density in mW/cm<sup>2</sup>

$P_{out}$  = output power to antenna in mW

$G$  = gain of antenna in linear scale

$\pi$  = 3.1416

$R$  = distance between observation point and center of the radiator in cm

$P_d$  is the limit of MPE, 1 mW/cm<sup>2</sup>. If we know the maximum gain of the antenna and the total power input to the antenna, through the calculation, we will know the distance  $r$  where the MPE limit is reached.

#### 5.1.2 Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.

### 5.1.3 EUT RF Exposure Evaluation

#### 1. exposure conditions for standalone operations

##### For Zigbee

Antenna Gain: 0.5dBi

Antenna Gain: The maximum Gain measured in fully anechoic chamber is 1.12 in linear scale.

Output Power Into Antenna & RF Exposure Evaluation Distance:

Channel	Frequency (MHz)	Max. Conducted Peak Output Power (dBm)	Output Power to Antenna (mW)	Power Density at R = 20 cm (mW/cm <sup>2</sup> )	Limit	MPE Ratios	Result
Lowest	2405	6.29	4.256	0.001	1.0	0.001	PASS

Note: Refer to report No. SZEM170300179203 for EUT test Max Conducted Peak Output Power value.

The distancer (5th column) calculated from the Fries transmission formula is far greater than 20 cm separation requirement.

##### For Zwave

Antenna Gain: 1.2dBi

Antenna Gain: The maximum Gain measured in fully anechoic chamber is 1.32 in linear scale.

Output Power Into Antenna & RF Exposure Evaluation Distance:

Channel	Frequency (MHz)	Max. Conducted Peak Output Power (dBm)	Output Power to Antenna (mW)	Power Density at R = 20 cm (mW/cm <sup>2</sup> )	Limit	MPE Ratios	Result
Low	908.4	-10.57	0.088	0.00002	0.61	0.00004	PASS

Note: Refer to Appendix B of Test Report SZEM170300179204 for EUT test Max Conducted Peak Output Power value.

The distancer (5th column) calculated from the Fries transmission formula is far greater than 20 cm separation requirement.

##### For NFC

Antenna Gain: 0dBi

Antenna Gain: The maximum Gain measured in fully anechoic chamber is 1 in linear scale.

Output Power Into Antenna & RF Exposure Evaluation Distance:

Channel	Frequency (MHz)	Max. Conducted Peak Output Power (dBm)	Output Power to Antenna (mW)	Power Density at R = 20 cm (mW/cm <sup>2</sup> )	Limit	MPE Ratios	Result
Low	13.56	-17.61	0.017	0.000003	0.979	0.000003	PASS

Note: Refer to Appendix B of Test Report SZEM170300179202 for EUT test Max Conducted Peak Output Power value.

The distancer (5th column) calculated from the Fries transmission formula is far greater than 20 cm separation requirement.

## 2. exposure conditions for simultaneous transmission operations

Simultaneous transmission MPE test is not required,because the Max. sum of the MPE ratios for Zigbee and Zwave is  $0.001+0.00004+0.000003=0.001 < 1$